

Notice of References Cited	Application/Control No 09/627,781	Applicant(s)/Patent Under Reexamination NAKAHARA ET AL.	
	Examiner Thien D Tran	Art Unit 2665	Page 1 of 1

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	B	US-6,567,374	05-2003	Bohnke et al.	370/203
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	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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